捷多邦,专业PCB打样工厂,24小时加急出**SN75LP185A** LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

SLLS257G - AUGUST 1996 - REVISED SEPTEMBER 1998

- Single-Chip TIA/EIA-232-F Interface for IBM™ PC/AT™ Serial Port
- Designed to Transmit and Receive 4-μs Pulses (Equivalent to 256 kbit/s)
- Less Than 21-mW Power Consumption
- Wide Supply-Voltage Range, 4.75 V to 15 V
- Driver Output Slew Rates Are Internally Controlled to 30 V/μs Max
- Receiver Input Hysteresis, 1000 mV Typ
- TIA/EIA-232-F Bus-Pin ESD Protection Exceeds:
 - 15-kV, Human-Body Model
 - 15-kV IEC1000-4-2, Air Gap
 - 8-kV IEC1000-4-2, Contact
- Three Drivers and Five Receivers Meet or Exceed the Requirements of TIA/EIA-232-F and ITU V.28
- Complements the SN75LP196
- Designed to Replace the Industry-Standard SN75185 and SN75C185 With the Same Flow-Through Pinout
- Packaged in Plastic Small-Outline Package

(TOP VIEW) V_{DD} [VCC RA1 RY1 19 RA2 1 3 RY2 18 RA3 [4 RY3 17 DY1 **1** 5 □ DA1 16 DY2 **∏** 6 Π DA2 15 RY4 RA4 14 DY3 **∏** 8 DA3 13 RA5 **1** 9 RY5 12 **GND** V_{SS} [

DW PACKAGE

description

The SN75LP185A is a low-power bipolar device containing three drivers and five receivers with 15 kV of ESD protection on the bus pins with respect to each other. Bus pins are defined as those pins that tie directly to the serial-port connector, including GND. The pinout matches the flow-through design of the industry-standard SN75185 and SN75C185. The flow-through pinout of the SN75LP185A allows easy interconnection of the UART and serial-port connector of the IBM PC/AT and compatibles. The SN75LP185A provides a rugged, low-cost solution for this function with the combination of the bipolar processing and 15 kV of ESD protection.

The SN75LP185A has internal slew-rate control to provide a maximum rate of change in the output signal of $30 \text{ V/}\mu\text{s}$. The driver output swing is nominally clamped at $\pm 6 \text{ V}$ to enable the higher data rates associated with this device and to reduce EMI emissions. Even though the driver outputs are clamped, they can handle voltages up to $\pm 15 \text{ V}$ without damage. All the logic inputs can accept 3.3-V or 5-V input signals.

The SN75LP185A complies with the requirements of TIA/EIA-232-F and ITU V.28. These standards are for data interchange between a host computer and peripheral at signaling rates up to 20 kbit/s. The switching speeds of the SN75LP185A support rates up to 256 kbit/s.

The SN75LP185A is characterized for operation from 0°C to 70°C.



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Function Tables

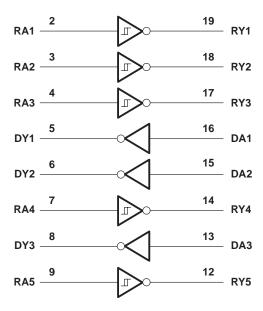
DRIVER

INPUT DA	OUTPUT DY
Н	L
L	Н
Open	L

RECEIVER

INPUT RA	OUTPUT RY
Н	L
L	Н
Open	Н

logic diagram (positive logic)





SN75LP185A LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Positive supply-voltage range (see Note 1): V _{CC}	0.5 V to 7 V
	0.5 V to 15 V
Negative supply-voltage range, V _{SS} (see Note 1)	
Input-voltage range, V _I : Receiver (RA)	
Driver (DA)	
Output-voltage range, V _O : Receiver (RY)	
Driver (DY)	
Electrostatic discharge (see Note 2): Bus pins (human-body model)	Class 3, A: 15 kV
Bus pins (machine model)	Class 3, B: 500 V
Bus pins (IEC1000-4-2, contact)	Class 3, C: 8 kV
Bus pins (IEC1000-4-2, air gap)	Class 3, D: 15 kV
All pins (human-body model)	Class 3, A: 5 kV
All pins (machine model)	Class 3, B: 400 V
Package thermal impedance, θ_{JA} (see Note 3)	97°C/W
Storage temperature range, T _{stq}	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal, unless otherwise noted.

- 2. Per MIL-STD-883 Method 3015.7
- 3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Vсс	Supply voltage (see Note 4)	4.75	5	5.25	V
V_{DD}	Supply voltage (see Note 5)	9	12	15	V
V _{SS}	Supply voltage (see Note 5)	-9	-12	-15	V
V _{IH}	High-level input voltage DA	2			V
VIL	Low-level input voltage DA			0.8	V
٧ _I	Receiver input voltage RA	-25		25	V
ІОН	High-level output current RY			-1	mA
loL	Low-level output current RY			2	mA
TA	Operating free-air temperature	0		70	°C

NOTES: 4. V_{CC} cannot be greater than V_{DD} .

5. The device operates down to $V_{DD}^- = V_{CC}$ and $|V_{SS}| = V_{CC}$, but supply currents increase and other parameters may vary slightly from the data-sheet limits.



SN75LP185A LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

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supply currents over the recommended operating conditions (unless otherwise noted)

PARAMETER	TEST C	TEST CONDITIONS				MAX	UNIT
Supply ourrent for Voc. Inc.	No load, All inputs at minimum V _{OH} or maximum V _{OL}	V _{DD} = 9 V,	$V_{SS} = -9 V$			1000	
Supply current for VCC, ICC		V _{DD} = 12 V,	$V_{SS} = -12 V$			1000	
Supply ourrent for \/>>		V _{DD} = 9 V,	V _{SS} = -9 V			450	μA
Supply current for V _{DD} , I _{DD}		V _{DD} = 12 V,	$V_{SS} = -12 V$			450	μΑ
Supply current for Vac Jac		V _{DD} = 9 V,	$V_{SS} = -9 V$			-625	
Supply current for VSS, ISS		$V_{DD} = 12 V$,	V _{SS} = -12 V			-625	

driver electrical characterisitics over the recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS				TYP [†]	MAX	UNIT
V-0	High lovel output voltage	V _{IL} = 0.8 V,	V _{DD} = 9 V,	$V_{SS} = -9 V$		5	5.8	6.6	V
VOH	High-level output voltage	$R_L = 3 k\Omega$, See Figure 1	V _{DD} = 12 V,	$V_{SS} = -12 V$,	See Note 6	5	5.8	6.6	V
\/a.	Low lovel output voltogo	V _{IH} = 2 V,	V _{DD} = 9 V,	V _{SS} = -9 V		-5	-5.8	-6.9	V
VOL	Low-level output voltage	$R_L = 3 \text{ k}\Omega$, See Figure 1	V _{DD} = 12 V,	$V_{SS} = -12 V$,	See Note 6	-5	-5.9	-6.9	V
lн	High-level input current	V _I at V _{CC}	V _I at V _{CC}					1	μΑ
I _I L	Low-level input current	V _I at GND	V _I at GND					-1	μΑ
IOS(H)	Short-circuit high-level output current	VO = GND or V	SS,	See Figure 2 a	nd Note 7		-30	– 55	mA
IOS(L)	Short-circuit low-level output current	$V_O = GND \text{ or } V_{DD}$, See Figure 2 and Note 7			30	55	mA		
r _o	Output resistance	$V_{DD} = V_{SS} = V$	CC = 0,	V _O = 2 V	·	300			Ω

NOTES: 6. Maximum output swing is nominally clamped at ±6 V to enable the higher data rates associated with this device and to reduce EMI emissions. The driver outputs may slightly exceed the maximum output voltage over the full V_{CC} and temperature ranges.

7. Not more than one output should be shorted at one time.



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driver switching characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PHL	Propagation delay time, high- to low-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega, C$	C _L = 15 pF, See Figure 1	300	800	1600	ns
tPLH	Propagation delay time, low- to high-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega, C$	C _L = 15 pF, See Figure 1	300	800	1600	ns
		V _{CC} = 5 V,	Using V _{TR} = 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF, See Note 8	375		2240	
tTLH	$V_{DD} = 12 \text{ V},$ Transition time. $V_{SS} = -12 \text{ V}.$	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 250 kbit/s, $C_L = 15 \text{ pF}$	200		1500	ns	
. =		See Figure 1 and	Using V _{TR} = ±2 V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133		1000	
			Using V _{TR} = ±3 V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF			2750	
	V _{CC} = 5 V,	Using V _{TR} = 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF, See Note 8	375		2240		
^t THL	Transition time,	$V_{DD} = 12 \text{ V},$ $V_{SS} = -12 \text{ V},$	Using V _{TR} = ±3 V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	200		1500	ns
		Using V _{TR} = ± 2 V transition region, Driver speed = 250 kbit/s, C _L = 15 pF	133		1000		
			Using V _{TR} = ±3 V transition region, Driver speed = 125 kbit/s, C _L = 2500 pF			2750	
SR	Output slew rate	V _{CC} = 5 V, V _{DD} = 12 V, V _{SS} = -12 V	Using V _{TR} = ±3 V transition region, Driver speed = 0 to 250 kbit/s, C _L = 15 pF	4	20	30	V/us

NOTES: 8. Equivalent to the SN75C185. The SN75LP185A output-voltage swing is clamped to about 70% of the typical SN75C185 output-voltage swing, and the specified limits reflect the reduced output swing.

9. Maximum output swing is limited to ±6 V to enable the higher data rates associated with this device and to reduce EMI emissions.

receiver electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TES.	T CONDITIONS	MIN	TYP	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	See Figure 3		1.6	2	2.55	V
V _{IT} -	Negative-going input threshold voltage	See Figure 3		0.6	1	1.45	V
VHYS	Input hysteresis, V _{IT+} V _{IT-}	See Figure 3		600	1000		mV
Vон	High-level output voltage	$I_{OH} = -1 \text{ mA}$		2.5	3.9		V
VOL	Low-level output voltage	$I_{OL} = 2 \text{ mA}$			0.33	0.5	V
	High-level input current	V _I = 3 V		0.43	0.6	1	mA
liΗ	nigh-level input current	V _I = 25 V		3.6	5.1	8.3	IIIA
1	Low level input current	V _I = −3 V		-0.43	-0.6	-1	mA
l IIL	Low-level input current	V _I = -25 V		-3.6	-5.1	-8.3	MA
los(H)	Short-circuit high-level output current	$V_{O} = 0,$	See Figure 5 and Note 7			-20	mA
los(L)	Short-circuit low-level output current	$V_O = V_{CC}$	See Figure 5 and Note 7			20	mA
R _{IN}	Input resistance	$V_{ } = \pm 3 \text{ V to } \pm 25 \text{ V}$		3	5	7	kΩ

NOTE 7: Not more than one output should be shorted at one time.



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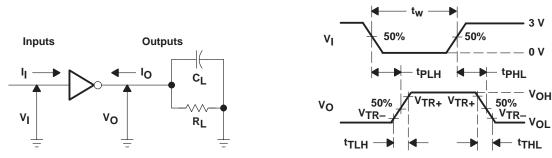
receiver switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF (unless otherwise noted) (see Figure 4)}$

	PARAMETER	MIN	TYP	MAX	UNIT
tPHL	Propagation delay time, high- to low-level output		400	900	ns
tPLH	Propagation delay time, low- to high-level output		400	900	ns
tTLH	Transition time, low- to high-level output		200	500	ns
tTHL	Transition time, high- to low-level output		200	400	ns
tSK(p)	Pulse skew tpLH tpHL		200	425	ns

PARAMETER MEASUREMENT INFORMATION

0 V

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NOTES: A. The pulse generator has the following characteristics: For $C_L < 1000$ pF: $t_W = 4 \mu s$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_\Gamma = t_f < 50$ ns. For $C_L = 2500$ pF: $t_W = 8$ μ s, PRR = 125 kbit/s, $Z_O = 50 \Omega$, $t_f = t_f < 50$ ns.

B. C_L includes probe and jig capacitance.

Figure 1. Driver Parameter Test Circuit and Waveform

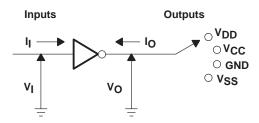


Figure 2. Driver IOS Test

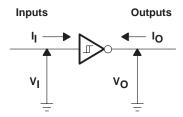
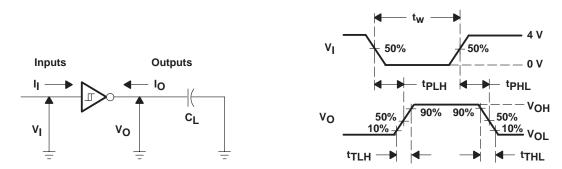


Figure 3. Receiver VIT Test



PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: t_W = 4 μ s, PRR = 250 kbit/s, Z_O = 50 Ω , t_Γ = t_f < 50 ns.

B. C_L includes probe and jig capacitance.

Figure 4. Receiver Parameter Test Circuit and Waveform

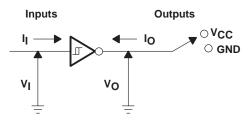


Figure 5. Receiver IOS Test

APPLICATION INFORMATION

Diodes placed in series with the V_{DD} and V_{SS} leads protect the SN75LP185A in the fault condition when the device outputs are shorted to ± 15 V and the power supplies are at low voltage and provide low-impedance paths to ground (see Figure 6).

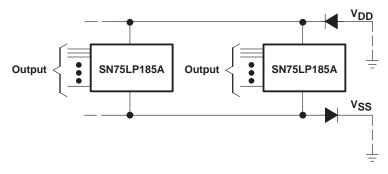


Figure 6. Power-Supply Protection to Meet Power-Off Fault Conditions of TIA/EIA-232-F



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